Application/Control No. 10/041,896 Applicant(s)/Patent Under Reexamination KRAUS ET AL. Examiner Yennhu B Huynh Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6072211	06-2000	Miller et al.	257/308
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